



Imaging Software NIS-Elements

Imaging Software

NIS-Elements

Advanced Solutions for your Imaging World

Nikon offers a total software solution for image capturing, archiving, and analysis

Why NIS-Elements?

NIS-Elements is an integrated software imaging platform which delivers comprehensive control of microscopes and peripheral devices, image capturing, documentation, image analysis and data management of up to six dimensions. This system contributes to experiment efficiency with intuitive image analysis features and database building capabilities developed to handle archiving and management of large numbers of multidimensional image files. Unified control of the entire imaging system offers significant benefits to users for cutting-edge research, such as live cell imaging.

Total Imaging Solution

Designed to serve the needs of advanced bioresearch, clinical, industrial and documentation professionals, NIS-Elements provides a totally integrated solution for users of Nikon and other manufacturers' accessories by delivering automated intelligence to microscopes, cameras, and peripheral components. The software optimizes the imaging process and workflow and provides the critical element of information management for system-based microscopy.



Highest Quality Optical Performance

The world-renowned Nikon CFI60 infinity optical system has effectively set a new standard for optical quality by providing longer working distances, higher numerical apertures, and the widest magnification range and documentation field sizes. Nikon's new objectives and accessories are specifically engineered for digital imaging.

Diverse Line of Powerful Digital Cameras

Nikon offers a full line of digital cameras, addressing the varied needs of users in multiple disciplines. Each Nikon digital camera is designed to work seamlessly with Nikon microscopes, peripherals, and software. With Nikon Digital Sight (DS) series cameras, even novice users can take beautiful and accurate microscopic images. For the advanced researcher, high resolution image capturing and versatile camera control is fast and simple.



Ar

NIS-Elements AR is optimized for advanced research applications, featuring fully-automated acquisition and device control through full 6D (X, Y, Z, Lambda (Wavelength), Time, Multipoint) image acquisition and a wide range of image analyses.

Br

NIS-Elements BR is suited for standard research applications, photodocumentation of fluorescent samples and image analysis, including intensity and counting measurements. It features acquisition and device control through 4D (up to four dimensions can be selected from X, Y, Z, Lambda (Wavelength), Time, Multipoint) acquisition.

D

NIS-Elements D supports color documentation requirements in bioresearch, clinical and industrial applications, with basic measuring and reporting capabilities.

Main Features

	AR	BR	D
	MDI (Multiple Document Interface)	MDI (Multiple Document Interface)	SDI (Single Document Interface)
Window style			
Dark color scheme	○	○	—
Industrial simple GUI	—	—	○
Camera control	○	○	○
Microscope control	○	○	○
Nikon made peripheral control	○	○	○
Non-Nikon peripheral control	○	○	○
Live image capture	○	○	○
Time-lapse image capturing (T)	○	○	△
Z-series image capturing (Z)	○	○	○
Multichannel image capturing (λ)	○	○	—
Multipoint image capturing (MP)	○	○	○
Multidimensional image capturing	● Up to 6D	● Up to 4D	—
Stimulation experiment	●	—	—
RAM capture	○	—	—
HDR image capture	○	●	●
AVI live-stream capture	○	○	○
Objective calibration	○	○	○
Capturing data savings (Meta-data)	○	○	○
Image filtering	○	△	△
Binary	○	△	▲
LUT (look up table)	○	○	○
Histogram	○	○	○
Manual measurement	○	○	○
Auto measurement	○	○	●
Intensity line profile	○	○	○
Intensity surface plot	○	○	○
Time (intensity) measurement	○	●	—
3D measurement	●	▲	▲
Volume measurement	○	—	—
Database	●	●	●
Macro	○	△	△
Advanced interpreter	○	●	●
Report generator	○	○	○
Live compare	○	●	●
Volume view	○	△	△
EDF (Extended depth of focus)	●	●	●
3D surface view	●	●	●
Ratio view	○	—	—
2D real time deconvolution	●	—	—
2D deconvolution	●	—	—
3D deconvolution	●	—	—
3D blind deconvolution	●	—	—
TTL/analog IO	●	●	●
Object classifier	●	—	—
2D/3D object tracking	●	—	—
Calcium & FRET	●	—	—
General analysis	●	—	—
HC Template	●	—	—
JOBS Editor	●	—	—
N-SIM analysis	●	—	—
N-SIM offline analysis	●	—	—
N-STORM analysis	●	—	—
N-STORM offline analysis*	●	—	—
Metalogical analysis	—	—	●
Illumination sequence	●	—	—
Stage incubator control	●	—	—
Dual camera support	●	—	—

○ : Full function △ : Limited function —: Not available ● / ▲ : Option

* N-STORM analysis is required.

Image Acquisition

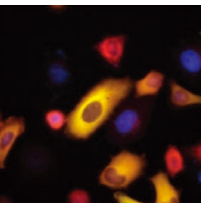
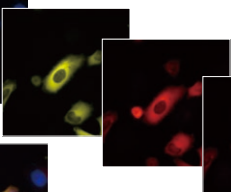
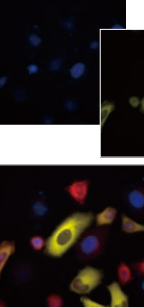
NIS-Elements offers the most suitable image acquisition for various applications with the integrated control of the camera, motorized microscope and peripheral devices.

Multichannel (multi color) Ar Br

NIS-Elements can acquire full bit depth multi-color images, combining multiple fluorescence wavelengths and different illumination methods (DIC, phase contrast etc.), while offering independently scalable channels.

Setup

Optical Conf.	Name	Comp. Color	T Pos.
<input checked="" type="checkbox"/> DAPI	DAPI	<div></div>	All
<input checked="" type="checkbox"/> FITC	FITC	<div></div>	All
<input checked="" type="checkbox"/> TRITC	TRITC	<div></div>	All
<input checked="" type="checkbox"/> DIC	DIC		All



Single-color images All-color merged image

Specified-color merged image

Z-series Ar Br D

Through motorized focus control, NIS-Elements reconstructs and renders 3D images from multiple Z-axis planes.

Top

Bottom

Reset

Step: 0.900 μ m

Bottom: 0.03 μ m

Top: 42.48 μ m

49 Steps

Range: 42.45 μ m

42.48 abs

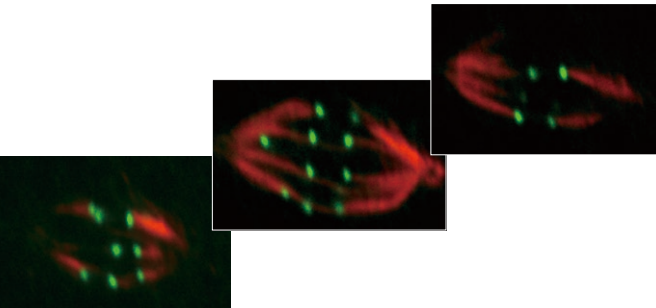
21.25 abs

0.03 abs

42.45 μ m

Relative Positions:

+42.45 μ m

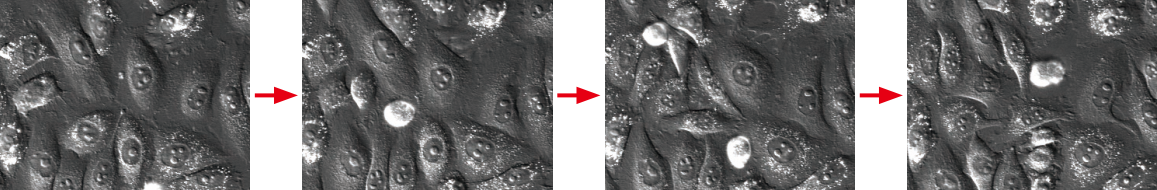


Time Lapse Ar Br D

Time lapse imaging in NIS-Elements is easily configurable simply by setting the time interval and duration of capture. The Perfect Focus System of the motorized inverted microscope Ti-E enables high-accuracy image capture without focus drifting even during extended time time-lapse experiments.

Time schedule

Phase	Interval	Duration	Loops
<input checked="" type="checkbox"/> #1	10 min	24 hour(s)	145
<input type="checkbox"/>			



Multipoint Experiments Ar Br D

NIS-Elements' motorized stage control offers automated travel to multiple stage points of the sample of a multi-well plate or dish. Stage points are memorized and can be saved and loaded for future imaging sessions.

Points

☒ Move Stage to Selected Point

Point Name	X [mm]	Y [mm]	Z [μ m]	PFS
<input checked="" type="checkbox"/> #1	2.425	0.356	1.48	4125
<input checked="" type="checkbox"/> #2	1.200	0.248	1.23	4152
<input checked="" type="checkbox"/> #3	0.567	0.862	0.53	4222
<input checked="" type="checkbox"/> #4	1.600	0.248	0.83	4123
<input checked="" type="checkbox"/> #5	1.542	0.887	...	Offset All X,Y,Z 4...


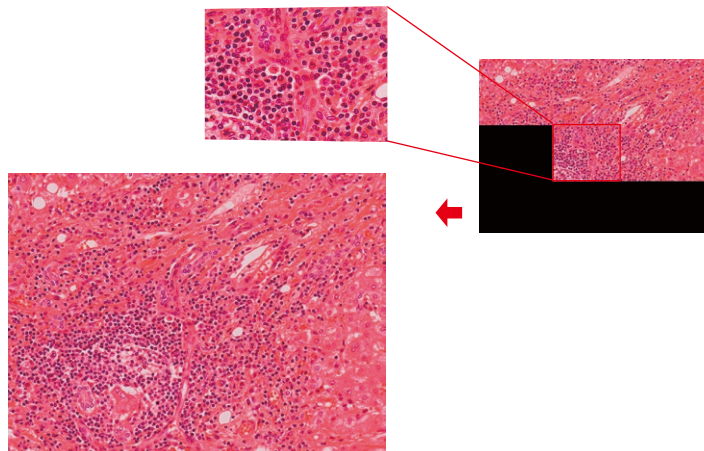
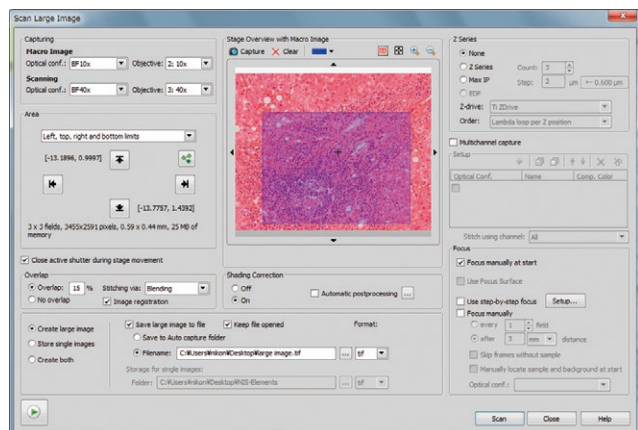


Image Stitching (Large image)

Ar Br D

Large Image Acquisition generates a single high-magnification wide field-of-view image by automatically stitching multiple adjacent frames from a multipoint acquisition using a motorized stage or from multiple single images captured from a previous session. Users can easily select image acquisition ranges and areas from low magnification images.



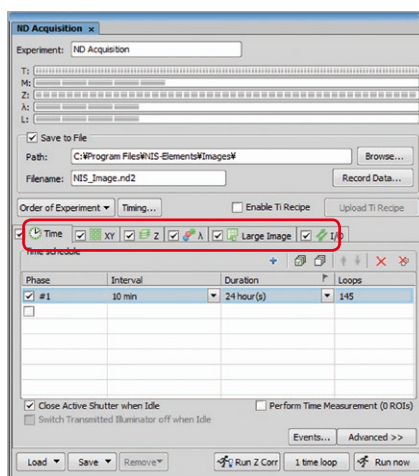
Multidimensional imaging

* Available dimensions vary depending on the package.

ND Acquisition

NIS-Elements captures images in a combination of multiple dimensions such as Time-Lapse, Multichannel, Z-series, and Multipoint. It is also possible to create and manage the acquisition of a multi-dimensional dataset with a thirty-minute time lapse of two wavelengths and a Z series across each well of a multi-well plate.

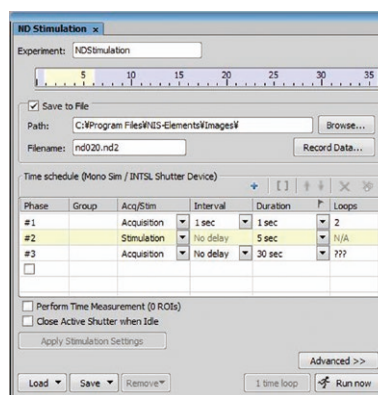
Option (Ar Br)



ND Stimulation

NIS-Elements controls photo stimulation and image acquisition.

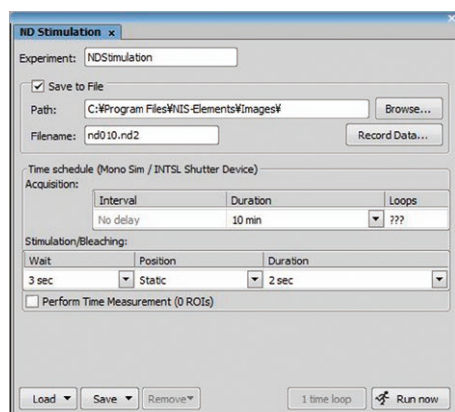
Option (Ar)



ND Simultaneous Stimulation

NIS-Elements enables image acquisition during photo stimulation.

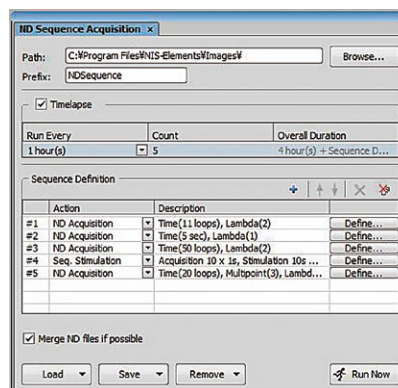
Option (Ar)



ND Sequential Acquisition

NIS-Elements allows various sequential imaging experiments to be combined with other functions, such as simultaneous photo stimulation and imaging, or multidimensional acquisition.

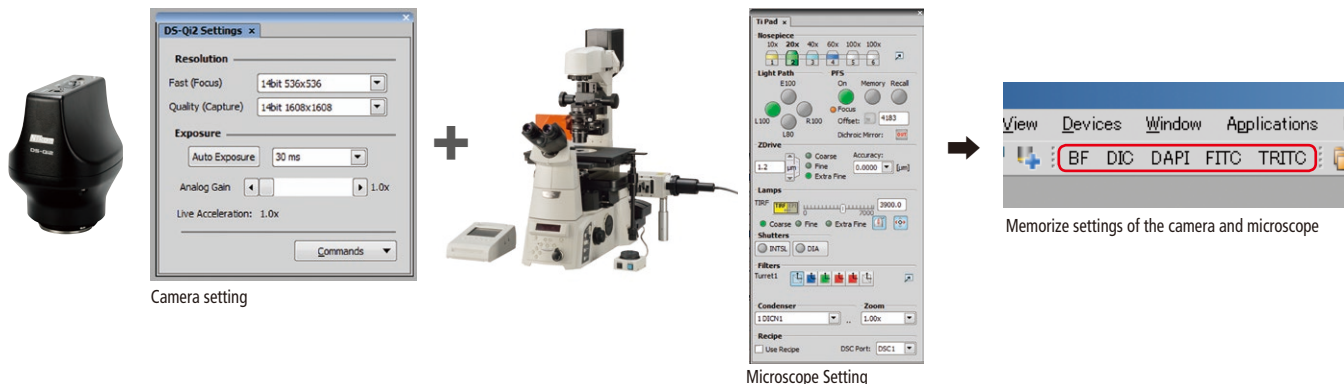
Option (Ar)



Optical Configuration

Ar Br D

Presets or 'Optical Configurations' can be saved for each observation method such as FITC fluorescence and DIC imaging, memorizing the settings of the microscope, camera and peripheral devices. The optical configurations are created through a one click set up and are displayed as icons in the tool bar for easy access and use.

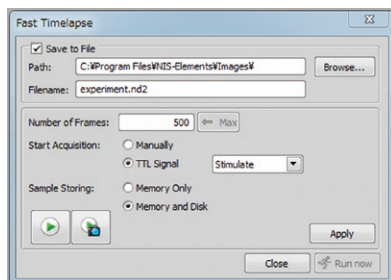


Movie Capture, Fast Image Capture

NIS-Elements has several options to observe and capture a sample's change and fast movement.

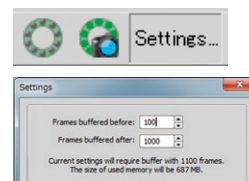
Fast Time Lapse

Fast Time Lapse is designed for ultra high-speed cameras. The hard disk drive can be used together with PC memory to enable a longer acquisition time.



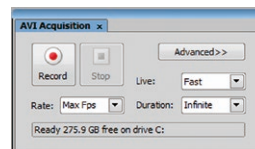
RAM Capture

RAM Capture allows for acquisition at the fastest possible rate of the camera. A RAM buffer is utilized to enable capture and retrieve a high speed time lapse, which aids in the capture of fleeting events such as calcium sparks, motility and translocation.



AVI Live-Stream Capture

AVI Acquisition automatically captures live data into an easily exportable and viewable AVI format.



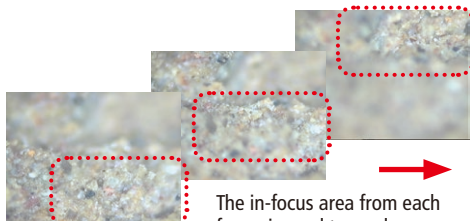
Extended Depth of Focus (EDF)

Option (Ar Br D)

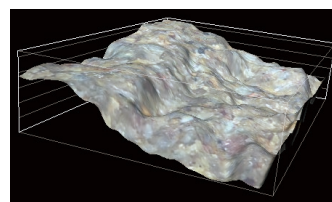


With motorized focusing

The EDF function selects the in-focus area from multiple Z-stack images, and produces one all-in-focus image. The composite image can be viewed and rotated as a virtual 3D image, as it contains Z-axis information.

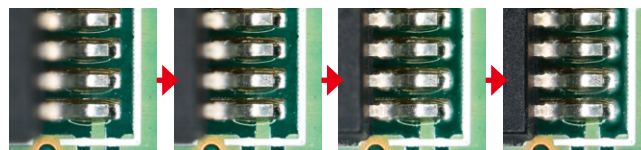


The in-focus area from each frame is used to produce one all-in-focus image.



With manual focusing

An all-in-focus image is created in real-time in synchronization with the rotation of the focus knob. While the focus is manually adjusted, the in-focus areas of the image at different depths are successively captured and combined for the EDF image.

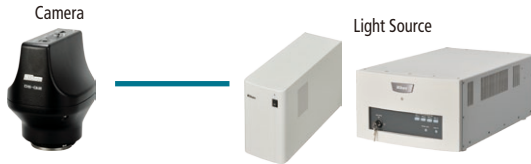


High Speed Device Operation by Triggering

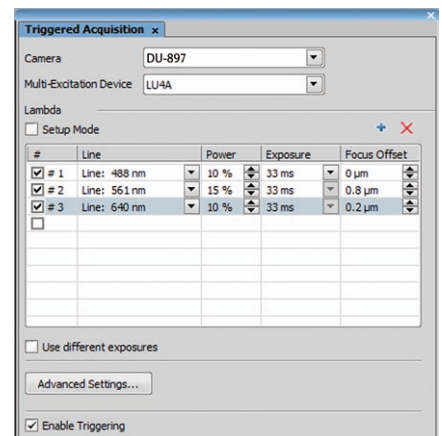
*Some cameras and devices are not compatible with these functions. For more information, please contact Nikon or an authorized representative.

Triggered Acquisition

Triggering external devices directly from the camera enables synchronized control of various devices such as the laser unit without passing through the PC. This allows for the fastest performance of the system components for multi-wavelength excitation in TIRF observation.

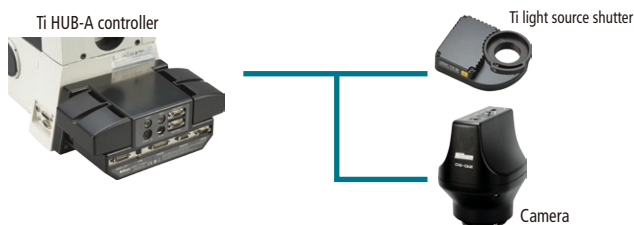


Ar Br

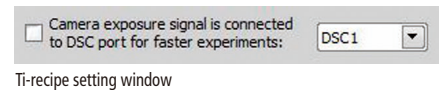


Ti-recipe

This function enables the HUB-A controller of the motorized inverted microscope Ti-E to control both image acquisition and the fluorescent shutter by directly connecting the camera and a HUB-A controller without passing through a PC. As a result of optimizing the communication times of all connected devices, acquisition times for multi-dimensional datasets are reduced.



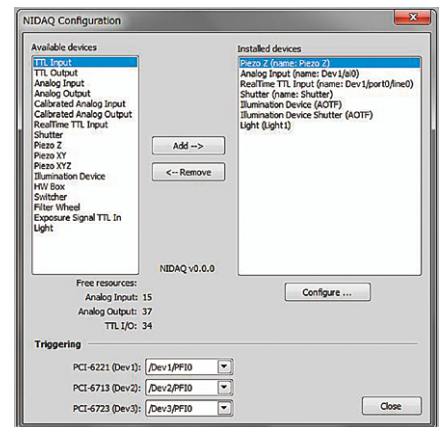
Ar Br



NI-DAQ Control

TTL and analog signal input/output with NI-DAQ Control enables experiments using various triggerable devices. Device triggering minimizes imaging time lag when used to control a Piezo Z device, shutter and wavelength switching, as it performs at the faster rate of the device without software communication delay. The calibration of analog signal output from devices to such as temperature enables data to be measured and observed during experiments.

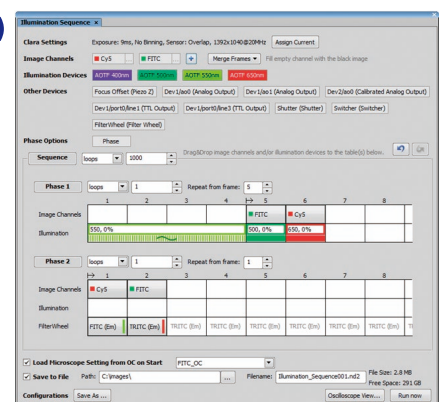
Option (Ar Br D)



Illumination Sequence Option

This module provides an easy-to-use graphical user interface for setting and running advanced real-time (triggered) acquisition experiments. It is a universal interface for camera-to-device triggering. An item drag-drop function makes it easy to create any complex illumination or stimulation procedure in a matter of minutes.

Option (Ar)

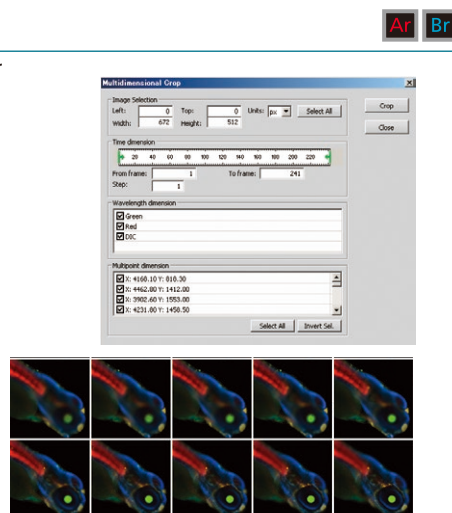
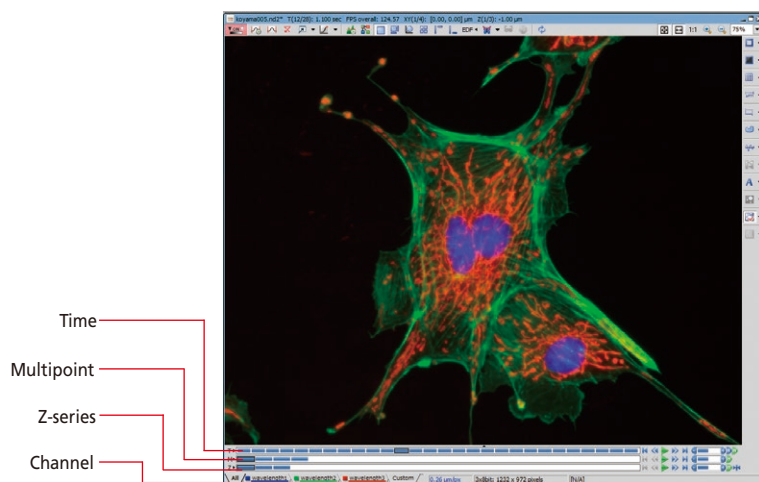


Display and Data Processing

Various methods are available for displaying and processing captured images and datasets.

Multi-dimensional Image Display

NIS-Elements displays time lapse, multi-channel, multiple X, Y, Z positions in an intuitive layout, which allows for automatic playback and the ability to select subsections of the data to be saved as a new file.



Merge Channels

Multiple single channel images (ex., two from three-channel acquisition images) can be merged together to create an overlay of full depth separately scalable images. With AR and BR, images can be merged by simply dragging the tab of one image onto another image. With D, images are merged by selecting each image for red, blue, green and brightfield channels.

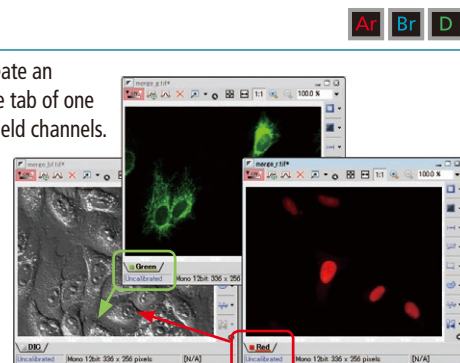
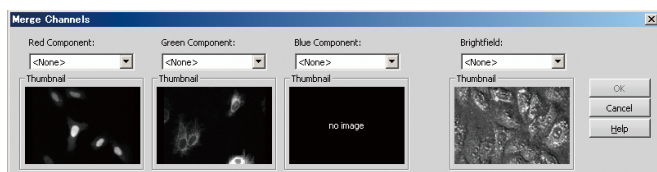
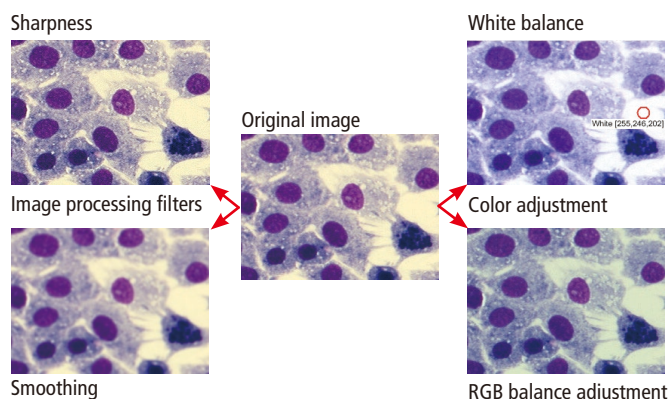


Image Processing

Image Filtering, Color Adjustment

*Usable functions vary depending on the package.

With NIS-Elements image processing tools, it is possible to modify image display and feature extraction using various filters for, for example, sharpness, smoothing and detection. White balance and RGB/HIS balance adjustment are additional available options.



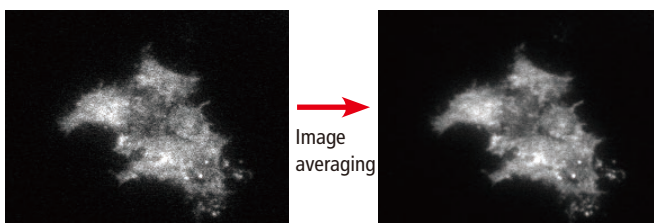
Arithmetic operation (Image arithmetic)

NIS-Elements enables arithmetic operations such as addition, subtraction, multiplication and division on an image or between multiple images. Arithmetic operation between multiple images is also possible.



Arithmetic operation (Image averaging)

NIS-Elements reduces the noise of an image by averaging multiple sequential images such as time-lapse images. Rolling averaging that does not reduce frame rate is available as well.

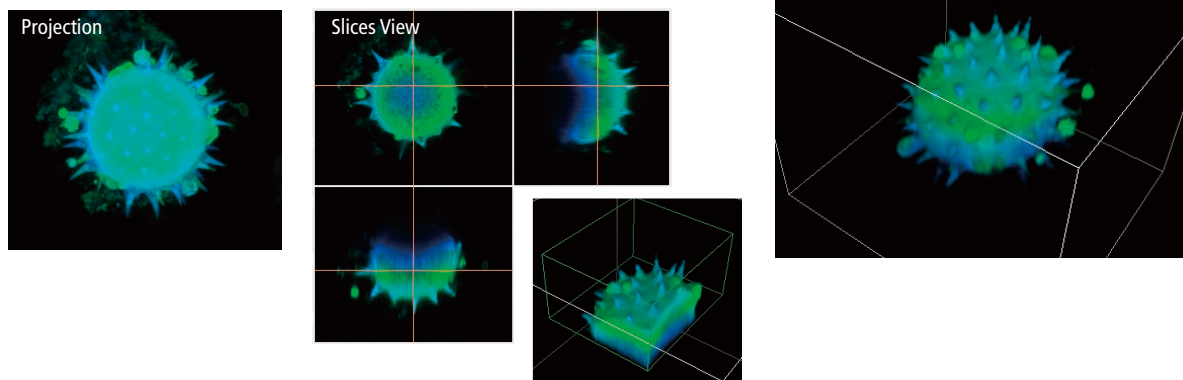


Z-Series Image Display (Volume View)

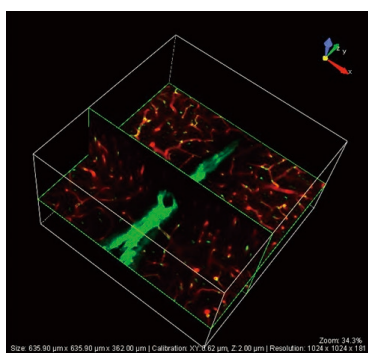
* Volume view and slice view are only possible with AR and BR.



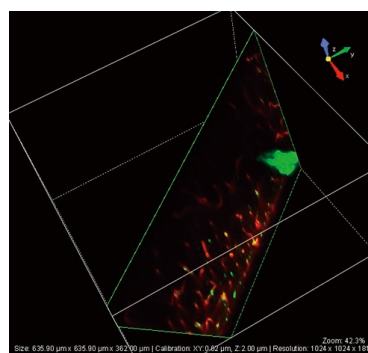
Z-series images can be displayed in various formats such as max. and min. projections, X-Z axis and Y-Z axis cross-sectional slice view and 3D volume view. Rotatable 3D volume rendered views from 3D datasets are easily converted to an AVI or MOV format for file sharing and export.



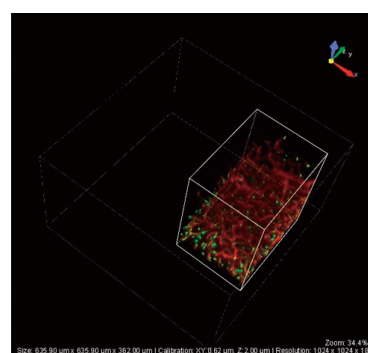
A combination of an AR package and a graphic board that supports DirectX 10 or later enables higher and more complex image display than ever.



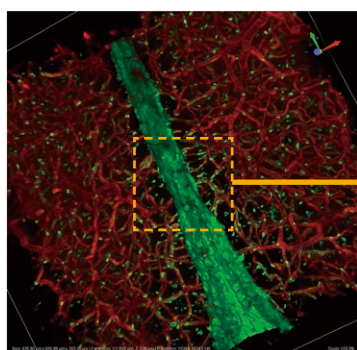
Cut Plane XY+YZ



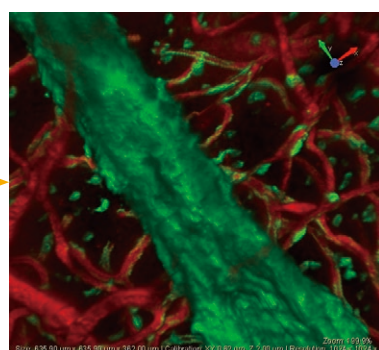
Cut Plane Any



Crop



High Resolution Display Mode



Mouse Brain
Sample mounted in RapiClear 1.47 (SunJin Lab Co., Taiwan) to render the tissue optically clear.

Deconvolution

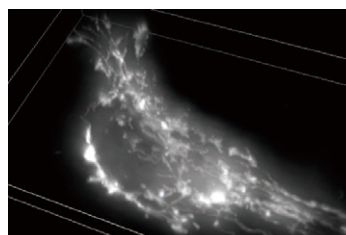
Option (AR)

3D Deconvolution

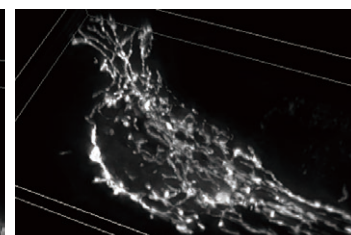
Haze and blur of the acquired fluorescence image can be eliminated. By reassigning out-of-focus intensities back to the spatial locations to where they originated, the intensity of the image is kept and allows for quantitative analysis. Algorithms for wide-field fluorescence, point-scanning confocal and spinning-disk confocal images are available.

2D Deconvolution

The 2D deconvolution module can be applied to a live image or an already acquired dataset. The module also allows the elimination of out-of-focus blur from live images and multidimensional images.



Before deconvolution



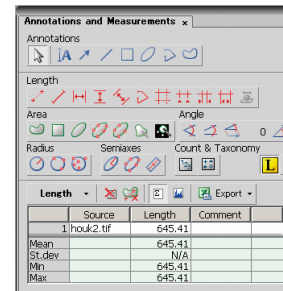
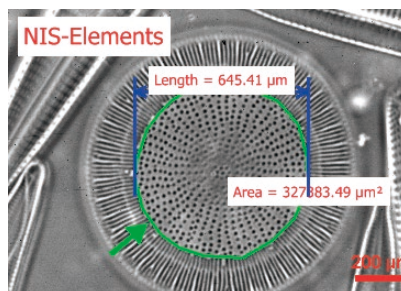
After deconvolution

Measurement and Analysis

Manual Measurement (Interactive Measurement) and Image Annotation

Ar Br D

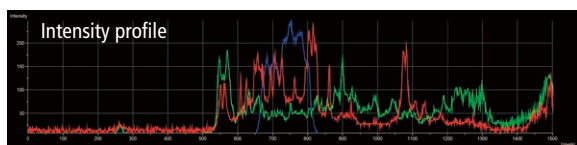
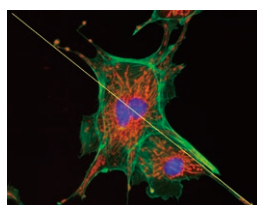
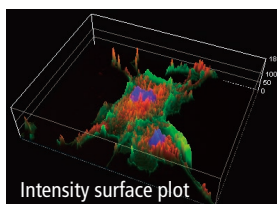
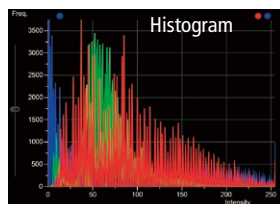
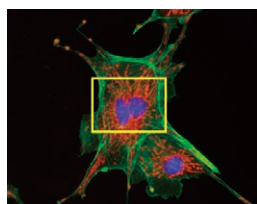
Interactive Measurement allows easy measurement of length and area by drawing lines or an object directly on the image. The results can be attached to the image, and also exported as text or to an Excel spreadsheet. Annotations such as arrows, circles, squares, text are also available display options.



Histogram/Intensity Line Profile/Intensity Surface Plot

Ar Br D

Histogram measurement measures the intensity distribution of pixels across the whole image or a defined region. An intensity line profile measurement shows the intensity distribution on a defined line. The Intensity Surface plot shows the intensity distribution of an image with the height of the z-axis line.

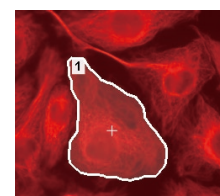


ROI Statistics

Ar Br

*Usable functions vary depending on the package. Common pixel measurements such as area, maximum or minimum intensity are possible with the user defined ROI (Region Of Interest).

ROI or multiple ROIs statistic results for a single image or a multi-dimensional dataset are displayed and easily exported as text or an excel file.



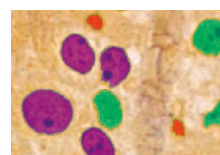
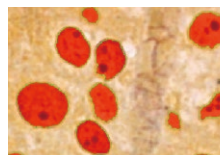
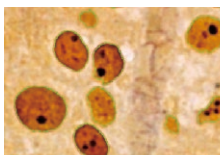
Feature	ROI	Binary
Area [μm²]	1583.56	0
Mean Intensity	120.54	0
Min Intensity	63.00	0
Max Intensity	206.00	0
Sum Intensity	5287736.00	0
StDev Intensity	28.36	0
Signal/Background	3.14 : 1	0

Area Fraction: N/A Selected ROIs: 1/1

Auto Measurement (Object Counting)

Ar Br Option (D)

Auto measurement measures the number or area of objects which are extracted from images by the creation of a binary layer through thresholding using RGB/HSI or intensity values. The results can be listed or exported as text or an excel file. It is possible to save and reuse thresholding parameters.



Classifier

Object Classifier

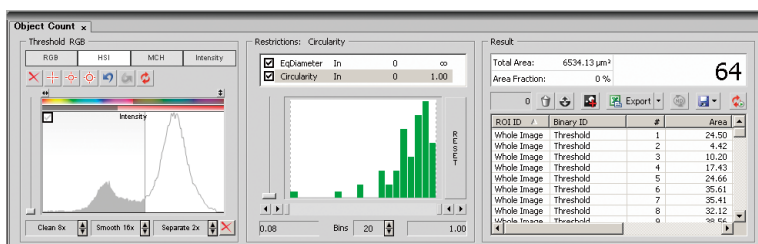
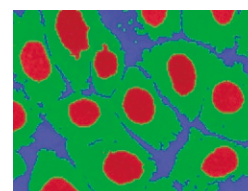
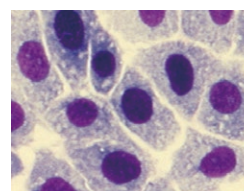
Option (Ar)

Object classifier uses objects identified by thresholding along with additional features such as shape factors, and other statistical methods including nearest neighbor and neural networks for classifying objects into multiple categories. It is also possible to teach the module based on interactive 'picking' of image pixels.

Pixel Classifier

Ar Br Option (D)

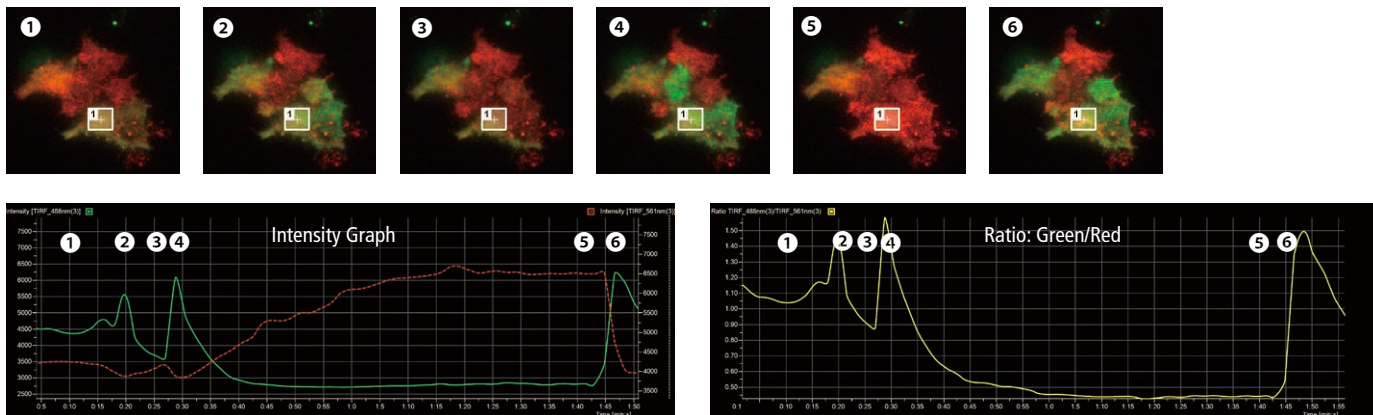
This function classifies each pixel in the image with RGB/HSI and intensity across the whole image. Results are reported in percentage and it is possible to save and reuse parameters across a large sample of images. Multiple binary layers are also displayed with multiple colors on the image and are available with other analysis tools within the software package.



Time (Intensity) Measurement

Option ()

Time measurement creates a graph of sequential intensity changes while time-lapse imaging or from captured time-lapse images. Ratio view function* allows the measurement of the ratio of two wavelengths across multiple ROIs and shows the ratio value by pixel. Numeric data and graph images are exportable and the measurements on the graph are available as well. (* Only with AR)

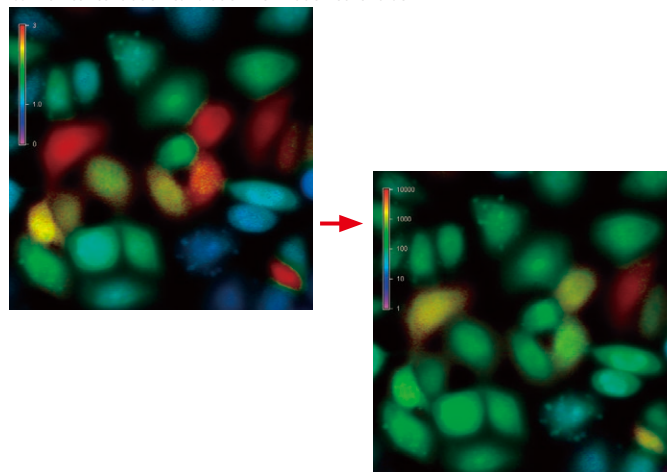


Calcium & FRET

Option ()

Ca^{2+} ion concentration calibration of the ratiometric fluorochrome Fura2, for example, is available using an easily configurable wizard. Corrected FRET image and FRET efficiency, reported in percentage is also available using three filter sets (three types of excitation-fluorescent combination: "Donor – Donor," "Acceptor – Acceptor" and "Donor – Acceptor") and two bleed-through factors.

Ca^{2+} ion concentration calibration from ratiometric value



FRET analysis

Create FRET Image

Donor - acceptor (Da): Donor - donor (Dd): Acceptor - acceptor (Aa): Acceptor - donor (Ad):

Thumbnail Thumbnail Thumbnail Thumbnail

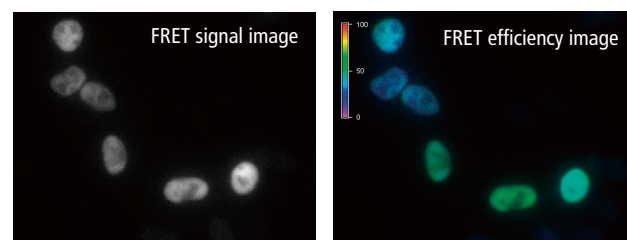
FRET Method

Method

Acceptor in FRET (CoA) Donor in Acceptor

Donor in FRET (CoB) Acceptor in Donor

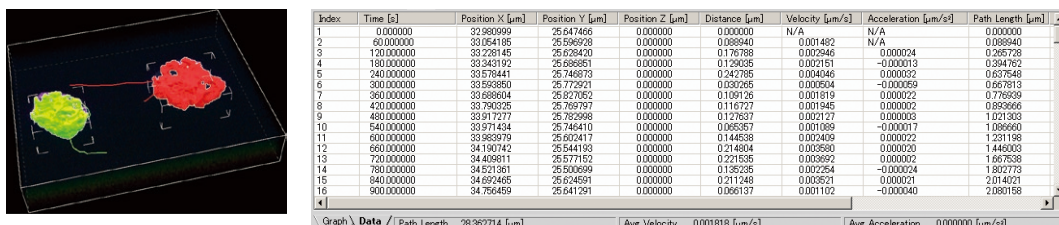
Calibrate... OK Load Cancel Save Help Remove



2D/3D Object Tracking

Option ()

Tracking of an object utilizes the threshold of objects over time and produces measurements such as velocity, acceleration, and distance from a specified origin. The tracking module offers both automated tracking and manual tracking methods.

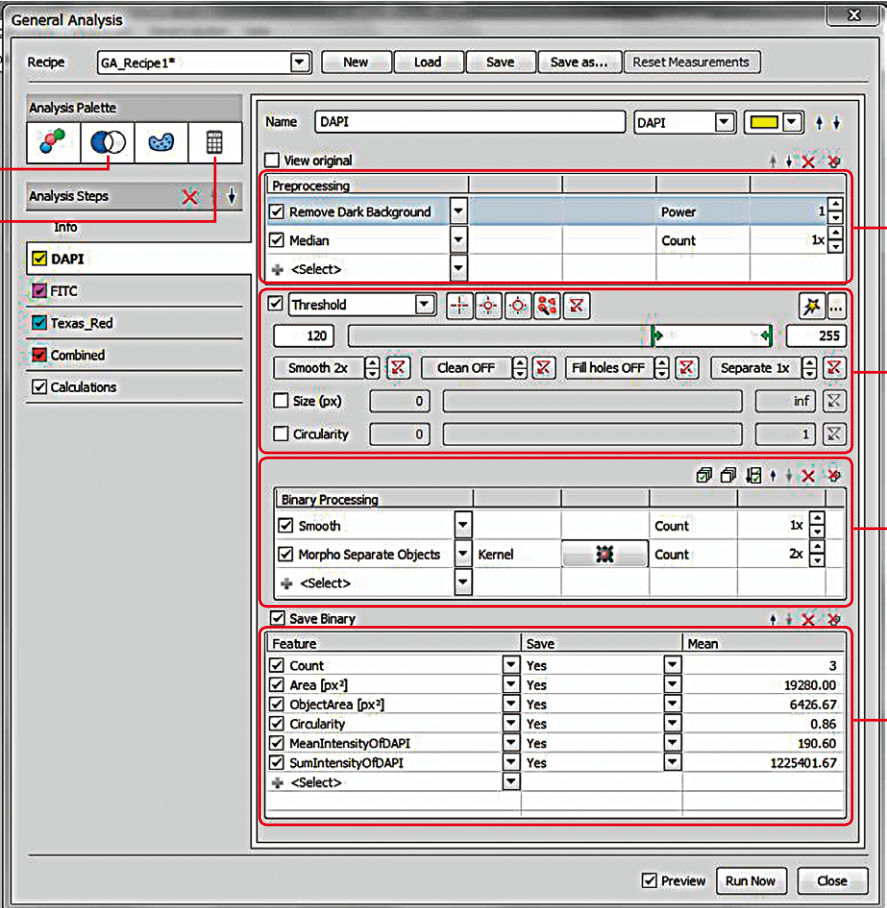


GA (General Analysis)

Option ()

General Analysis streamlines the setup of image analysis combining functions, such as image preprocessing and thresholding, processing of binary images and features, and measurement settings.

- GA creates a new measurement area by combining multiple binary layers, and creates a new measurement parameter by applying these custom measurement settings.
- Each setting can be stored as a recipe that can be rerun for routine analysis under the same conditions across multiple datasets.

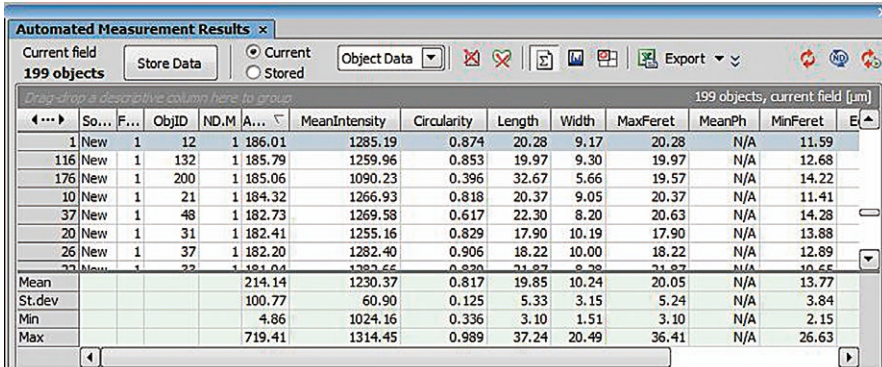


The screenshot shows the 'General Analysis' dialog box with the 'Recipe' set to 'GA_Recipe1*'. The 'Analysis Palette' on the left includes 'DAPI', 'FITC', 'Texas_Red', 'Combined', and 'Calculations'. The main panel shows the 'DAPI' analysis setup. Annotations point to various sections:

- Combine binary layers**: Points to the 'Analysis Steps' section on the left.
- Create new measurement lists**: Points to the 'Info' section on the left.
- Setup of multiple analysis tasks**: Points to the 'Preprocessing' section.
- Image preprocessing**: Points to the 'Remove Dark Background' and 'Median' checkboxes.
- Image thresholding**: Points to the 'Threshold' section, including the 'Threshold' value (120 to 255) and 'Smooth 2x' checkbox.
- Processing of binary layers (measurement areas)**: Points to the 'Binary Processing' section, including 'Smooth' and 'Morpho Separate Objects' checkboxes.
- Measurement parameters**: Points to the 'Save Binary' section, which lists features like 'Count', 'Area [px²]', 'ObjectArea [px²]', 'Circularity', 'MeanIntensityOfDAPI', and 'SumIntensityOfDAPI'.

Output of analyzed results

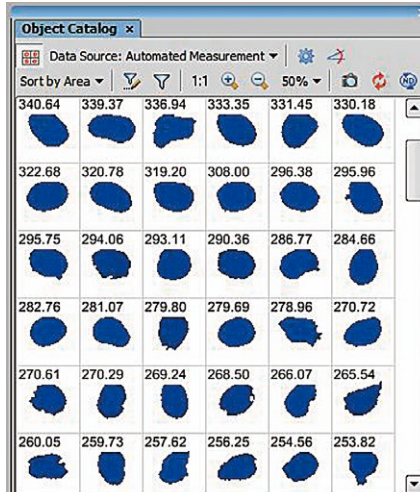
Automated Measurement results



The 'Automated Measurement Results' window displays a table with 199 objects. The table includes columns for object ID, area, circularity, length, width, and various intensity measurements. The 'Mean' row shows the average values for each column.

	So...	F...	ObjID	ND.M	A...	MeanIntensity	Circularity	Length	Width	MaxFerret	MeanPh	MinFerret	E
1	New	1	12	1	186.01	1285.19	0.874	20.28	9.17	20.28	N/A	11.59	
116	New	1	132	1	185.79	1259.96	0.853	19.97	9.30	19.97	N/A	12.68	
176	New	1	200	1	185.06	1090.23	0.396	32.67	5.66	19.57	N/A	14.22	
10	New	1	21	1	184.32	1266.93	0.818	20.37	9.05	20.37	N/A	11.41	
37	New	1	48	1	182.73	1269.58	0.617	22.30	8.20	20.63	N/A	14.28	
20	New	1	31	1	182.41	1255.16	0.829	17.90	10.19	17.90	N/A	13.88	
26	New	1	37	1	182.20	1282.40	0.906	18.22	10.00	18.22	N/A	12.89	
Mean					214.14	1230.37	0.817	19.85	10.24	20.05	N/A	13.77	
St.dev					100.77	60.90	0.125	5.33	3.15	5.24	N/A	3.84	
Min					4.86	1024.16	0.336	3.10	1.51	3.10	N/A	2.15	
Max					719.41	1314.45	0.989	37.24	20.49	36.41	N/A	26.63	

Object catalog



The 'Object Catalog' window displays a grid of 25 object images, each with its corresponding area and intensity values. The 'Data Source' is 'Automated Measurement'.

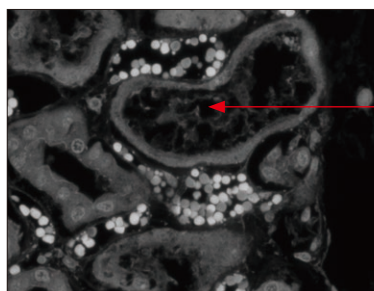
Area	Intensity	Area	Intensity	Area	Intensity
340.64	339.37	336.94	333.35	331.45	330.18
322.68	320.78	319.20	308.00	296.38	295.96
295.75	294.06	293.11	290.36	286.77	284.66
282.76	281.07	279.80	279.69	278.96	270.72
270.61	270.29	269.24	268.50	266.07	265.54
260.05	259.73	257.62	256.25	254.56	253.82

Others

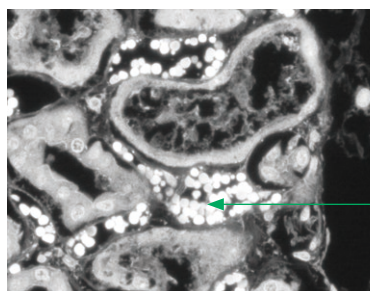
HDR (High Dynamic Range) Image Acquisition

Ar Option (Br D)

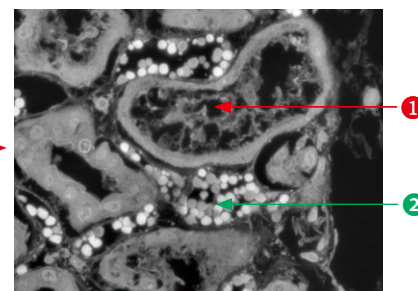
HDR creates an image with appropriate brightness in both the dark and bright regions in a sample by combining multiple images acquired with different exposure settings. It is also possible to create HDR image using multiple captured images.



300-msec exposure: ① area is underexposed



600-msec exposure: ② area is overexposed

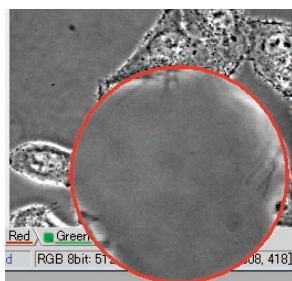


HDR image: captures both ① and ② areas with optimal exposure

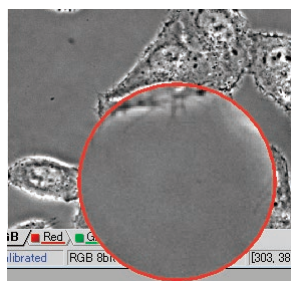
Background Compensation

Ar Br D

Background correction uses previously captured images to correct uneven background brightness while imaging or of captured images.



Before compensation

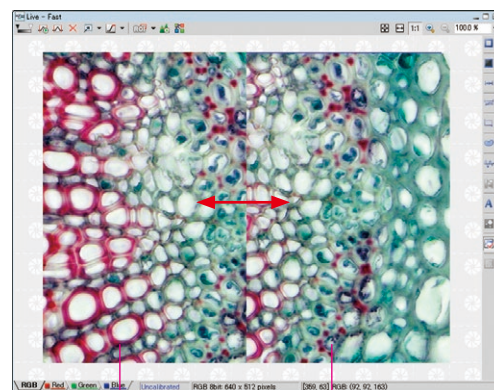


After compensation

Live Image Comparison

Ar Option (Br D)

Live Compare enables easy image comparison between a sample image and a live image. Live observation side by side with a paused live image is also available in split screen mode.



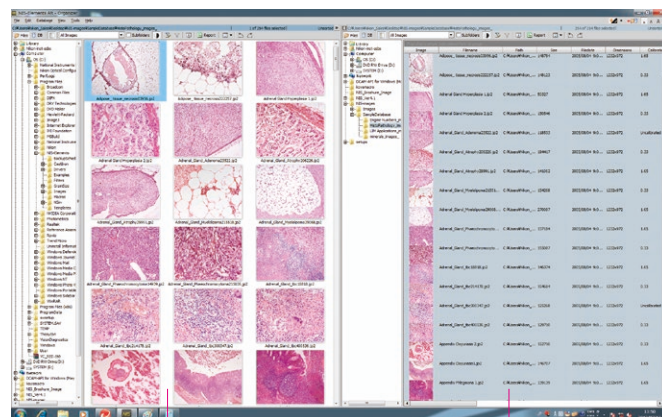
Live image

Paused live image

Database

Option (Ar Br D)

Using the organizer function, captured images are displayed in thumbnails for easy retrieval of the desired image. By simply clicking on the thumbnail image in this view, the image is easily opened. Sorting and filtering this database of images and datasets using acquisition details such as objective settings, date and author is an easy method for data management as well.



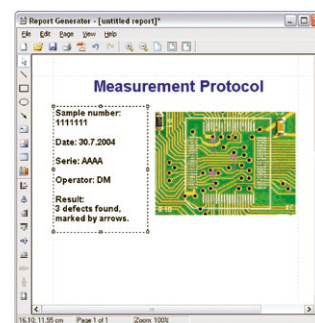
Organizer

Database

Report Generation

Ar Br D

Images captured with NIS-Elements have information such as acquisition details and analysis results, allowing export and PDF conversion of the image and the associated image header and data information.



User Rights/Control

Ar Br D

For safe system management, it is possible to individually limit each user authorization using the user account of Windows® (such as the Administrator or Guest) or the user account of NIS-Elements. It limits the authorization and modification of the device settings (microscopes, cameras or others), optical configuration and layout editing.



The HC Template is a dedicated software module within NIS-Elements.

- It allows fully automated acquisition and analysis of a large number of high-content, multi-dimensional images with integrated control of the high-speed motorized focus and stage of Ti-E motorized inverted microscope, camera and peripheral devices.
- HC Template within NIS-Elements allows for quick experimental setups with several autofocusing options and an immediate view of measurement data well by well during acquisition and via a heat map for trend observation and further analysis.



High Content Analysis System

- The microscope-based High Content Analysis System combined with the Ti-E offers a wide range of interchangeable options, including a full range of camera models, such as high-speed and high-definition cameras, as well as a choice of magnifications and fluorescence filters.
- High-speed peripheral devices are optionally available to boost throughput of integrated devices. These include the high-speed piezo Z-objective positioner for fast autofocusing and the automatic plate loader for auto analysis of multiple well plates.

High Content Analysis System

Microscope	Motorized inverted microscope ECLIPSE Ti-E
Compatible well plate types	6-, 12-, 24-, 48-, 96-well plates, 384-well plate (for fluorescence observation)
Multiple FOV experiments	Center, Covering, Random, Random+Center and Regular pattern in each well
Illumination methods	Fluorescence, Phase contrast, DIC
Image acquisition	Multichannel, Time lapse, Multidimensional imaging
Acquisition speed	2 min/96 well plate (1 point/well, 30 msec/shot, without Z stacking, PFS (Perfect Focus System))
Data visualization	Plate view, Sample labeling, Heat map, Graphing
Recommended objectives	S Fluor 4x, Plan Fluor 10x, S Plan Fluor ELWD 20xC/40xC (phase contrast objectives can also be used for image acquisition)
Recommended imaging devices	Camera : DS-Qi2 (Nikon), Zyla sCMOS (Andor technology), iXon3 DU-897 (Andor technology) Confocal microscope : A1+, A1R+, C2+ (Nikon)

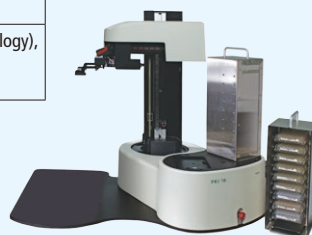


High-speed Piezo Z-objective Positioner (Option)

For fast autofocusing

Z travel range	Up to 200 μ m
Z travel speed	30 msec
Repeatability	\pm 5 nm

(Physik Instrumente (PI) GmbH & Co. KG)



Automatic Plate Loader (Option)

For automatic imaging with multiple well plates

Number of well plates	Up to 20 plates
Loading speed	30 sec/plate
Barcode reader option	1D and 2D barcode

(Prior Scientific Instruments Ltd.)

Sequential HC Template workflow from acquisition to analysis

1 Experimental setups

The wizard format simplifies settings for each experimental parameter. It also enables sequential operational settings, such as well plate definition, acquisition patterns in a well, wavelengths, autofocus and image analysis.

Define general job parameters

- Z-stack
- Sample labelling
- Autofocus
- Sending task completion by e-mail or SNS

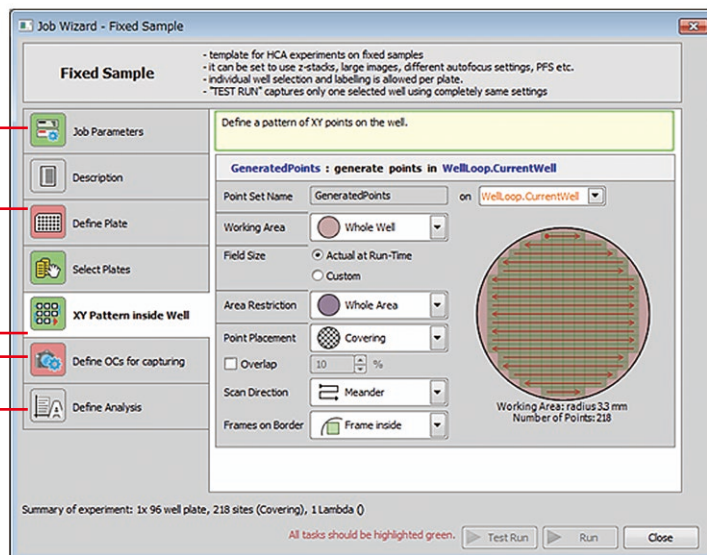
Well plate setting

- Define well plate to use
- Select well plate for image capture
- Define XY image capture pattern inside a well

Define optical configurations for image capture

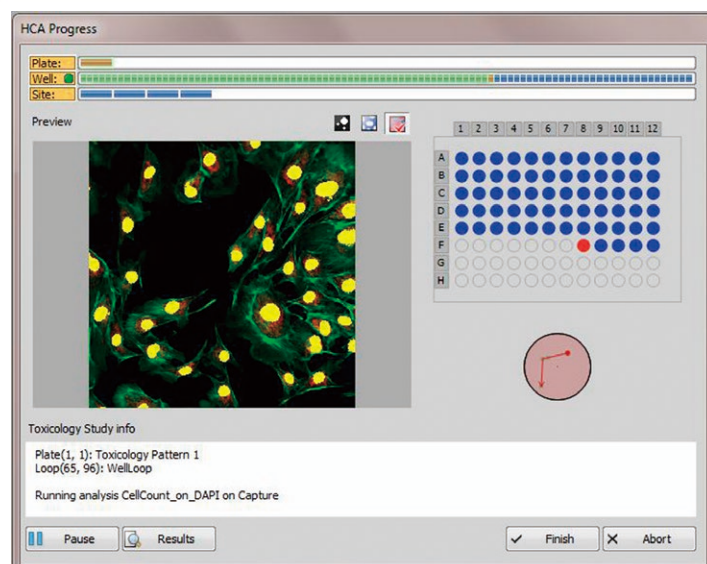
Define analysis

(Set the custom image analysis using General Analysis on page 12.)



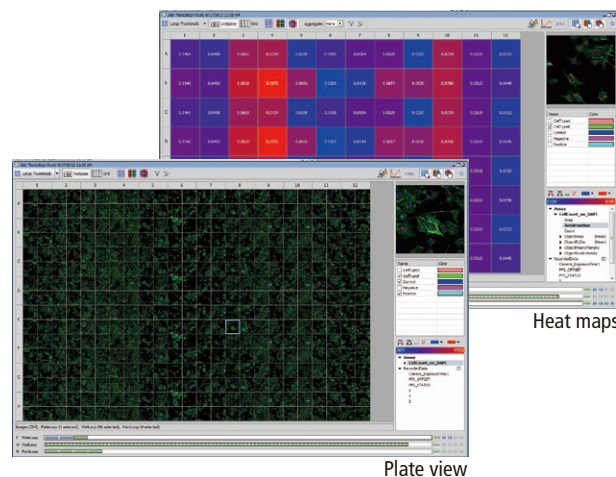
2 Progress display

Current well-plate acquisition point is displayed in real time along with a live image. Image analysis is conducted during image acquisition, allowing for immediate observation of data collection and experimental status.



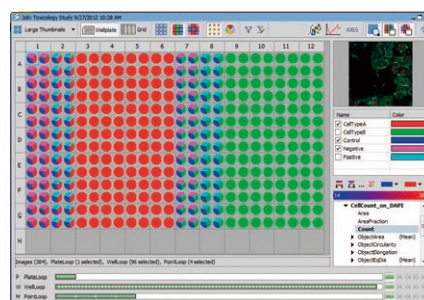
3 Results display

Various formats are available for displaying results. Plate view is a centralized view that shows acquired images and all associated data. Sample labeling manages image data by linking cells by name, type and quantity of reagent. Heat maps visualize trends in measurement results and analytical values. Graphical displays of analytical values such as histograms, scatter plots and bar graphs are also available.

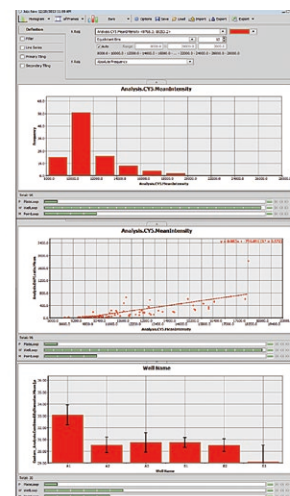


Heat maps

Plate view



Sample labeling



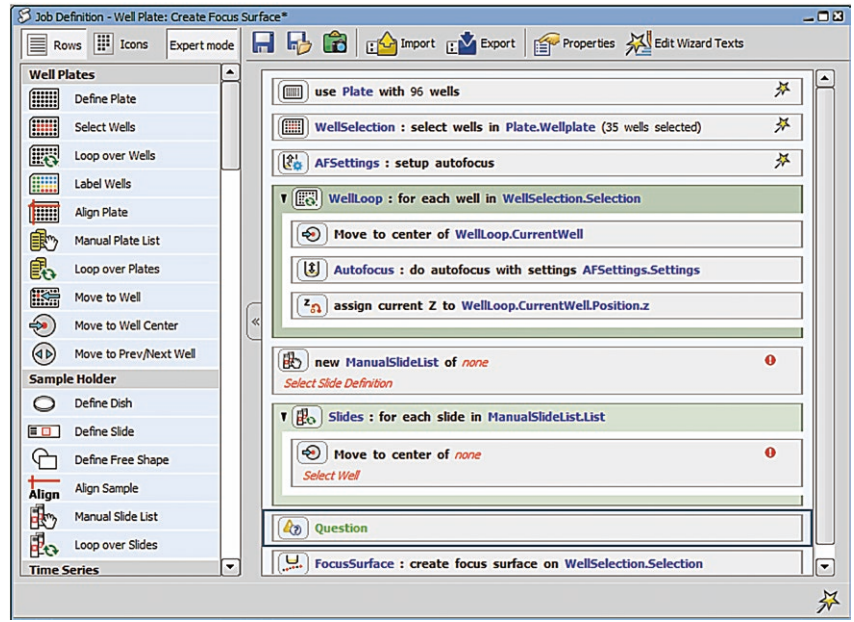
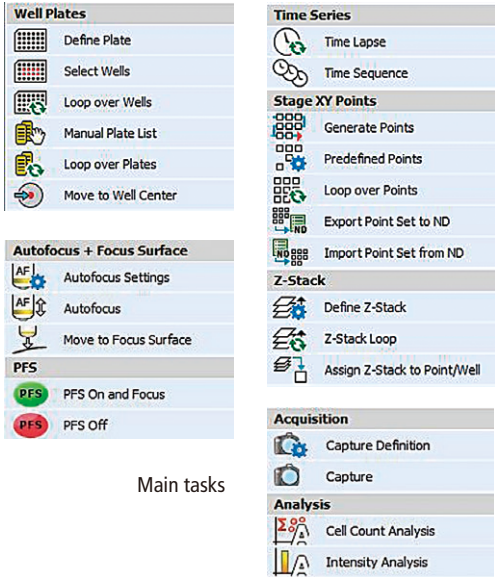
Visual programming tool that enables creation of highly flexible experimental templates

JOBS Editor

Option ()

JOBS Editor is a visual programming tool that can create experimental templates (JOBS) simply by dragging and dropping the settings for "tasks" in the sequence of experimental procedures, such as sample definition, image acquisition settings and analysis settings, into the JOBS Editor window.

The HC Template offers streamlined operation of high-throughput imaging/analysis. However, JOBS Editor enables easy creation of more complex and custom experimental templates, from image acquisition to analysis, by providing a number of available tasks, without the need of advanced data programming knowledge and the need for creating a macro.



For offline analysis of high-content data

Remote Database/JOBS Viewer* (for HC Template and JOBS Editor)

Option ()

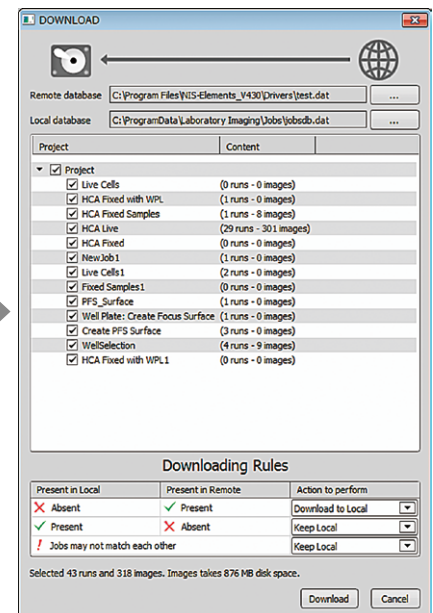
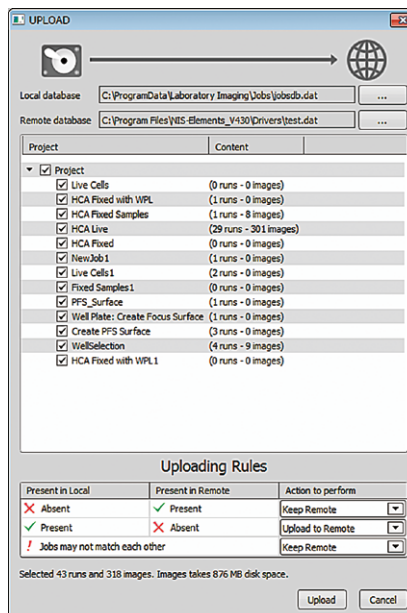
Enables image analysis and management of a large volume of high-content imaging data on an offline PC.

Operating image acquisition and data analysis on separate computers boost total throughput.

General Analysis module is required for offline image analysis.

*JOBS Viewer is not available in some regions.

- Remote Database allows offline exchange of data between computers and network servers.
- Using JOBS Viewer and/or General Analysis, images acquired through HC Template or JOBS can be analyzed on a dedicated offline computer.



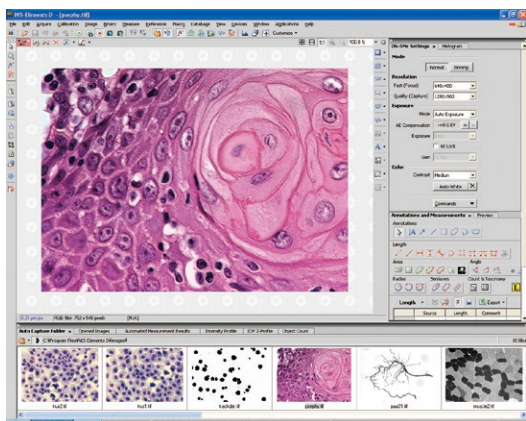
Data upload/download using Remote Database

GUI Option

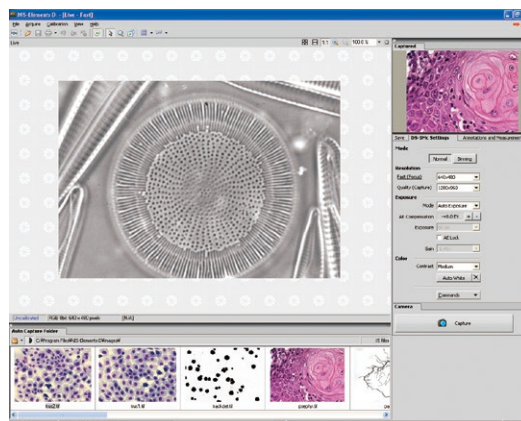
Industrial Simple GUI

D

With D package, the simple GUI mode provides controls for the most common operations such as image capture and simple measurement.



Standard GUI mode: Displays all functions of D package

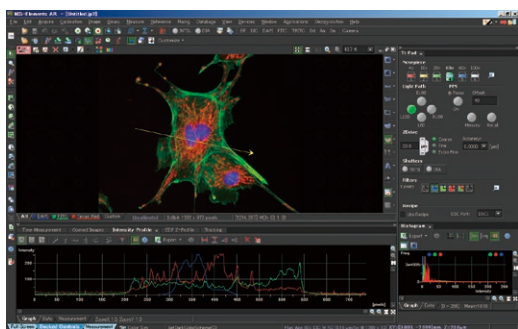


Simple GUI mode: Display only image capturing and measurement

Dark Color Scheme

Ar Br

This popular display option mode has a brightness level interface color palette suitable for use in a dark microscopy room.



Layout Manager

Ar Br D

Layout manager enables customizing layouts of controls, toolbars and menus and application (image acquisition or measurement). Saving custom layouts is possible and accessible through one-click tab access.



Off-line Analysis and Viewer Software

NIS-Elements is compatible not only with Nikon products but also with third-party products such as high-sensitivity CCD cameras and peripheral devices. Third party devices and cameras are easy to integrate through the NIS-Elements intuitive install and device manager.

Off-line Package for Analysis

The NIS-Elements off-line software package offers analysis tools such as intensity measurements and object counting of tiff and multi-dimensional format images captured with Nikon's microscopes and third-party software.

Viewer Software

This is free software for image display of single images and datasets captured using NIS-Elements. Possible views include Tile View, Max/Min Projections and 3D Volume View. Saving multi-dimensional files into TIFF format is available as well. The viewer is downloadable from the Nikon website.



Software Upgrade

SUA License

NIS-Elements can be upgraded for one year from the date of purchase. The Software Upgrade Agreement (SUA) License, which is purchasable in one-year license segments, extends the access to the latest version of NIS-Elements.



Supporting Broad Microscope Imaging

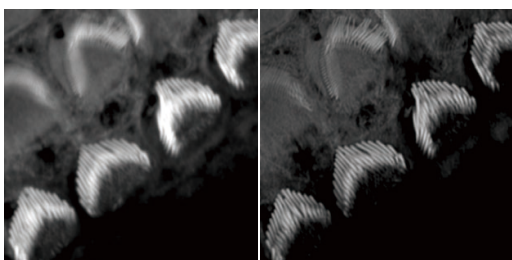
NIS-Elements is a common software platform for Nikon microscope systems, which allows the comprehensive control of wide range of functions for cameras, confocal imaging systems and super resolution microscopes.

NIS-Elements C

NIS-Elements C-ER

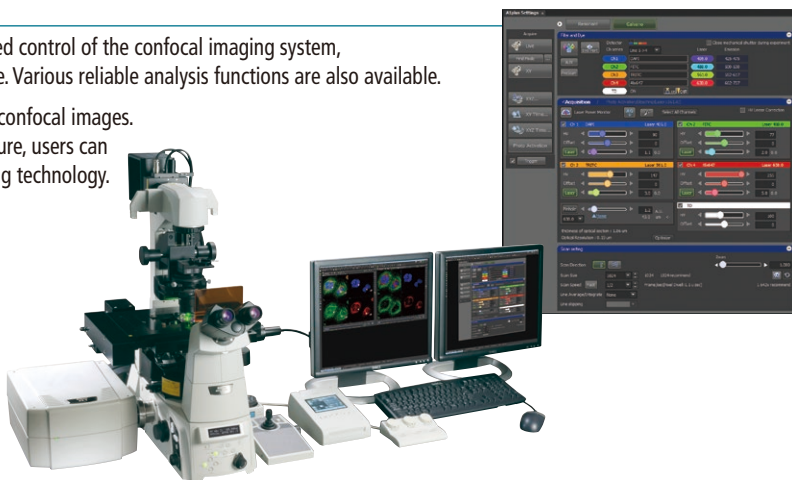
NIS-Elements C/NIS-Elements C-ER imaging software enables integrated control of the confocal imaging system, microscope and peripheral devices with a simple and intuitive interface. Various reliable analysis functions are also available.

NIS-Elements C-ER can provide resolution enhancement capability for confocal images. Without changing the conventional confocal image acquisition procedure, users can easily achieve enhanced resolution by utilizing unique image processing technology.



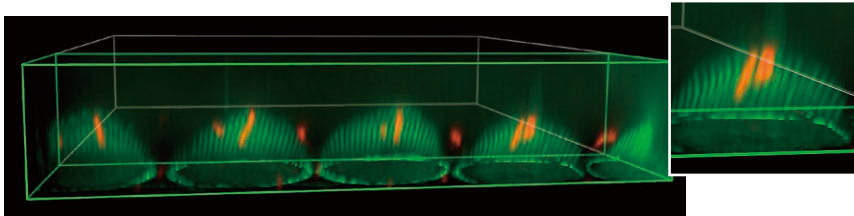
Conventional confocal image NIS-Elements C-ER image

Apical surfaces of auditory epithelia of mouse cochleae were stained by Atto-565-phalloidin at postnatal day 2. Photos courtesy of: Dr. Hideru Togashi, Division of Molecular and Cellular Biology, Kobe University Graduate School of Medicine.



N-SIM Analysis option

N-SIM Analysis option allows control of Nikon Super Resolution Microscope N-SIM, which can achieve an image resolution of 115nm (in 3D-SIM mode) and temporal resolution of up to 0.6 sec/frame using high frequency Structured Illumination.

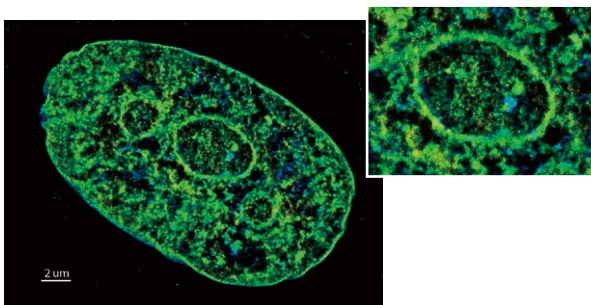


Luminal surface of the organ of Corti at postnatal day 1. (Mouse)
Green: F-actin, red: acetylated-tubulin
Photos courtesy of: Drs. Kanoko Kominami, Hideru Togashi, and Yoshimi Takai, Division of Molecular and Cellular Biology, Kobe University Graduate School of Medicine



N-STORM Analysis option

N-STORM Analysis option enables control of Nikon Super Resolution Microscope N-STORM, which realizes an incredible image resolution of approx. 20nm by utilizing Stochastic Optical Reconstruction Microscopy (STORM).



A human fibroblast labeled with EdU-Alexa Fluor 647 to visualize DNA with 3D-STORM.
Photo courtesy of: Jason Otterstrom, Ph.D., Melike Lakadamyali, Ph.D., The Institute of Photonic Sciences (ICFO), Castelldefels



NIS-Elements Supported Devices (ver. 4.50 or later)

Nikon Cameras

DS-Ri2
DS-Qi2
CCU: DS-U2/L2 (for camera head DS-2Mv/Vi1/
2MBW/2MBWc/5M/5Mc/Fi1/Fi1c/Qi1/Ri1)
CCU: DS-U3/L3 (for camera head DS-Vi1/Fi1/Fi1c/
Qi1/Ri1/Fi2)
DQC-FS²

Third-party Cameras

Photometrics

Evolve
QuantEM
CoolSNAP HQ2
CoolSNAP ES²
Cascade 128+²
Cascade II 512²
Cascade 1K²

Andor Technology

Luca S, Luca R
iXon+ 897, 888, 885
iXon X3
iXon Ultra
iKon-M
Clara
Neo sCMOS
Neo 5.5 sCMOS
Zyla 5.5 sCMOS (3-Tap, 10-Tap)
Zyla 4.2 sCMOS

QImaging

Retiga EXi Aqua/Blue
Retiga 2000R - Mono/Color
Retiga SRV + RGB-HM-S Slide
Rolera EMC2
QIClick
QICAM

Hamamatsu

ImagEM
ImagEM 1K
ImagEM X2
ORCA-R2
ORCA-Flash2.8
ORCA-Flash4.0
ORCA-Flash4.0 LT
ORCA-D2
ORCA
C9100-02, C9100-12

PCO

pco.edge 3.1 (Only compatible with mono sensor)
pco.edge 4.2 LT
pco.edge 4.2
pco.edge 5.5 (Only compatible with mono sensor)

Imaging Source

DFK/DMK 31,41,51,72 series
DFK/DMK 23U274
DFK/DMK 23UP031
DMK 23UM021
DFK 23U445

Others

TWAIN Device²

Nikon Microscope Devices

Biological Microscope Ti (HUBC/A, HUBC/A-U, Ti-LAPP System⁴)
Biological Microscope TE2000 (Perfect Focus System)
Biological Microscope 90i (ND filter, Stage, DIH-E/M)
Biological Microscope 80i (DIH-E/M, D-FL-E, C-Box/C-Box2)
Biological Microscopes Ni-E, Ni-U, Ci-E
Fixed-stage Microscope FN1+ D-DH-E-A1¹
Stereo Microscope SMZ25/18/1270i/1270/800N
Multizoom Microscope AZ100M
Industrial Microscope LV-N Series³
Measuring Microscope MM-400/800²
Metallographic Microscope MA200
Inspection Microscopes L200N/L300N
C-HGFIE HG Fiber Illuminator Intensilight
C-LED FI Epi-FI LED Illuminator
Laser Module LU-N Series
LV-NCNT-N Nosepiece controller
NI-SH-CON

Third-party Devices

Prior Scientific

ProScan III
ProScan II
Prior PCI II
OptiScan II ES10
NZ100,200,400 NanoStageZ
ES10ZE

Ludl Electronic Products

MAC5000, MAC6000

Märzhäuser Wetzlar

TANGO Desktop, Tango PCI
LSTEP

Vincent Associates (Uniblitz)

VCM-D1

Sutter Instrument

Lambda 10-2, 10-3, SC, 10-B, XL

Physical Instrument

PI E-662, 665 (RS232)
PI E-545+P-545.2R7
PI E-545+P-545.3R7

Photometrics

Dual View

ASI (Applied Scientific Instrumentation)

MS-2000
FW-1000
SC-2000

National Instruments

TTL Input/Output (NI Card)

Tokai Hit

WSKM

OKO-Lab

H301-T-UNIT-BL-PLUS + CO2-O2-UNIT-BL
UNO-COMBINED-CONTROLLER

Mad City Labs

Nano-Drive

Yokogawa

CSU-W1¹⁴
CSU-X1¹⁴

Supported Operation System

Windows 7 Professional SP1 (32/64-bit version)

* NIS-Elements Ar and C are only compatible with the 64-bit version.

NIS-Elements is compatible with all common file formats, such as JP2, JPG, TIFF, BMP, GIF, PNG, ND2, JFF, JTF, AVI, ICS/IDS. ND2 is a special format for NIS-Elements. ND2 allows storing sequences of images acquired during nD experiments. It contains information about the hardware settings and the experiment conditions and settings.

*1 Only compatible with 64-bit version OS

*2 Not compatible with 64 bit version OS

*3 Not compatible with LV-DAF Auto Focus Unit

*4 Only compatible with NIS-Elements AR



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